SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

- D-Type Flip-Flops in a Single Package With 3-State Bus Driving True Outputs
- **Full Parallel Access for Loading**
- **Buffered Control Inputs**
- **Package Options Include Plastic** Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

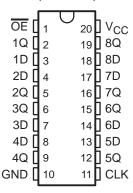
description

These octal D-type edge-triggered flip-flops feature 3-state outputs designed specifically for drivina highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

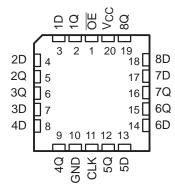
On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

A buffered output-enable (\overline{OE}) input places the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pullup components.

SN54ALS374A, SN54AS374 . . . J PACKAGE SN74ALS374A, SN74AS374 . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS374A, SN54AS374 . . . FK PACKAGE (TOP VIEW)



OE does not affect internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54ALS374A and SN54AS374 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS374A and SN74AS374 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each flip-flop)

| | INPUTS | | | | | |
|----|------------|---|-------|--|--|--|
| OE | CLK | D | Q | | | |
| L | \uparrow | Н | Н | | | |
| L | \uparrow | L | L | | | |
| L | H or L | Χ | Q_0 | | | |
| Н | X | Χ | Z | | | |

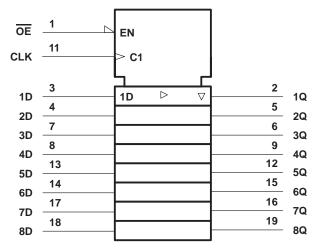


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

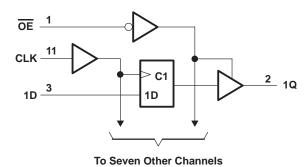


SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

logic symbol[†]



logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

| Supply voltage range, V _{CC} | \dots -0.5 V to 7 V |
|---|-------------------------|
| Input voltage range, V _I | $-0.5\ V$ to 7 V |
| Voltage applied to a disabled 3-state output | \dots –0.5 V to 5.5 V |
| Package thermal impedance, θ _{JA} (see Note 1): DW package | 58°C/W |
| N package | 69°C/W |
| Storage temperature range, T _{stq} | –65°C to 150°C |

^{\$} Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

| | | SN54ALS374A | | '4A | SN7 | UNIT | | |
|----------------|--------------------------------|-------------|-----|-----|-----|------|------|------|
| | | MIN | NOM | MAX | MIN | NOM | MAX | UNIT |
| Vcc | Supply voltage | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| VIH | High-level input voltage | 2 | | | 2 | | | V |
| VIL | Low-level input voltage | | | 0.7 | | | 0.8 | V |
| ІОН | High-level output current | | | -1 | | | -2.6 | mA |
| loL | Low-level output current | | | 12 | | | 24 | mA |
| T _A | Operating free-air temperature | -55 | | 125 | 0 | | 70 | °C |



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| DADAMETER | TEST CONDITIONS | | SN5 | 4ALS374 | IA | SN7 | UNIT | | |
|-----------------|---|----------------------------|--------------------|------------------|------|--------------------|------------------|------|------|
| PARAMETER | 1651 00 | TEST CONDITIONS | | TYP [†] | MAX | MIN | TYP [†] | MAX | UNII |
| VIK | V _{CC} = 4.5 V, | I _I = -18 mA | | | -1.5 | | | -1.5 | V |
| | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ | $I_{OH} = -0.4 \text{ mA}$ | V _{CC} -2 | | | V _{CC} -2 | | | |
| Voн | V _{CC} = 4.5 V | $I_{OH} = -1 \text{ mA}$ | 2.4 | 3.3 | | | | | V |
| | VCC = 4.5 V | $I_{OH} = -2.6 \text{ mA}$ | | | | 2.4 | 3.2 | | |
| Voi | \\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\ | I _{OL} = 12 mA | | 0.25 | 0.4 | | 0.25 | 0.4 | V |
| VOL | V _{CC} = 4.5 V | I _{OL} = 24 mA | | | | | 0.35 | 0.5 | ٧ |
| lozh | $V_{CC} = 5.5 \text{ V},$ | V _O = 2.7 V | | | 20 | | | 20 | μΑ |
| lozL | $V_{CC} = 5.5 \text{ V},$ | V _O = 0.4 V | | | -20 | | | -20 | μΑ |
| lį | $V_{CC} = 5.5 \text{ V},$ | V _I = 7 V | | | 0.1 | | | 0.1 | mA |
| lін | V _{CC} = 5.5 V, | V _I = 2.7 V | | | 20 | | | 20 | μΑ |
| IIL | V _{CC} = 5.5 V, | V _I = 0.4 V | | | -0.2 | | | -0.2 | mA |
| lo [‡] | V _{CC} = 5.5 V, | V _O = 2.25 V | -20 | | -112 | -30 | | -112 | mA |
| | | Outputs high | | 11 | 20 | | 11 | 19 | |
| lcc | V _{CC} = 5.5 V | Outputs low | | 19 | 28 | | 19 | 28 | mA |
| | | Outputs disabled | | 20 | 31 | | 20 | 31 | |

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

| | | SI | | SN54ALS374A | | SN74ALS374A | |
|-----------------|-----------------|------------------|------|-------------|-----|-------------|------|
| | | | MIN | MAX | MIN | MAX | UNIT |
| fclock | Clock frequency | | | 30 | | 35 | MHz |
| t _W | Pulse duration | CLK high or low | 16.5 | | 14 | | ns |
| t _{su} | Setup time | Data before CLK↑ | 10 | | 10 | | ns |
| th | Hold time | Data after CLK↑ | 4 | | 0 | | ns |

switching characteristics over recommended operating conditions (unless otherwise noted (see Figure 3)

| PARAMETER | FROM | то | SN54ALS374A | | SN74AL | UNIT | |
|------------------|-------------|----------|-------------|-----|--------|------|------|
| PARAMETER | (INPUT) | (OUTPUT) | MIN | MAX | MIN | MAX | UNIT |
| fmax | | | 30 | | 35 | | MHz |
| t _{PLH} | CLK | | 3 | 14 | 3 | 12 | ne |
| t _{PHL} | CLK | Q | 5 | 17 | 5 | 16 | ns |
| ^t PZH | | | 3 | 18 | 3 | 17 | ne |
| t _{PZL} | ŌĒ | Q | 5 | 21 | 5 | 18 | ns |
| ^t PHZ | ŌĒ | Q | 1 | 11 | 1 | 10 | 20 |
| t _{PLZ} | OE . | Q . | 2 | 19 | 2 | 18 | ns |



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

recommended operating conditions

| | | SN54AS374 | | | SI | UNIT | | |
|-----------------|--------------------------------|-----------|-----|-----|-----|------|-----|------|
| | | MIN | NOM | MAX | MIN | NOM | MAX | UNIT |
| Vcc | Supply voltage | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| VIH | High-level input voltage | 2 | | | 2 | | | V |
| V _{IL} | Low-level input voltage | | | 0.7 | | | 0.8 | V |
| ІОН | High-level output current | | | -12 | | | -15 | mA |
| loL | Low-level output current | | | 32 | | | 48 | mA |
| TA | Operating free-air temperature | -55 | | 125 | 0 | | 70 | °C |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| DADAMETED | TEST CO | MOITIONS | SN | 154AS374 | 4 | SN | UNIT | | |
|----------------------|---|--------------------------|--------------------|----------|------|--------------------|------|------|------|
| PARAMETER | 1231 00 | TEST CONDITIONS | | TYP† | MAX | MIN | TYP† | MAX | UNIT |
| VIK | V _{CC} = 4.5 V, | I _I = -18 mA | | | -1.2 | | | -1.2 | V |
| | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$ | $I_{OH} = -2 \text{ mA}$ | V _{CC} -2 | | | V _{CC} -2 | | | |
| VOH | V 45V | I _{OH} = -12 mA | 2.4 | 3.2 | | | | | V |
| | V _{CC} = 4.5 V | I _{OH} = -15 mA | | | | 2.4 | 3.3 | | |
| V | V _{CC} = 4.5 V | I _{OL} = 32 mA | | 0.29 | 0.5 | | | | V |
| V _{OL} | | I _{OL} = 48 mA | | | | | 0.34 | 0.5 | V |
| lozh | V _{CC} = 5.5 V, | V _O = 2.7 V | | | 50 | | | 50 | μА |
| lozL | V _{CC} = 5.5 V, | V _O = 0.4 V | | | -50 | | | -50 | μА |
| IĮ | V _{CC} = 5.5 V, | V _I = 7 V | | | 0.1 | | | 0.1 | mA |
| lіН | V _{CC} = 5.5 V, | V _I = 2.7 V | | | 20 | | | 20 | μА |
| OE, CLK | V 55V | V- 0.4.V | | | -0.5 | | | -0.5 | A |
| l _{IL} Data | V _{CC} = 5.5 V, | $V_1 = 0.4 V$ | | | -3 | | | -2 | mA |
| IO [‡] | V _{CC} = 5.5 V, | V _O = 2.25 V | -30 | | -112 | -30 | | -112 | mA |
| ICC | | Outputs high | | 77 | 120 | | 77 | 120 | |
| | V _{CC} = 5.5 V | Outputs low | | 84 | 128 | | 84 | 128 | mA |
| | | Outputs disabled | | 84 | 128 | | 84 | 128 | |

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

| | | | SN54A | S374 | SN74A | UNIT | |
|-----------------|-----------------|------------------|-------|------|-------|------|------|
| | | | MIN | MAX | MIN | MAX | UNIT |
| fclock | Clock frequency | | | 100* | | 125 | MHz |
| | Pulse duration | CLK high | 5.5* | | 4 | | 20 |
| t _W | ruise duration | CLK low | | | 3 | | ns |
| t _{su} | Setup time | Data before CLK↑ | 3* | | 2 | | ns |
| t _h | Hold time | Data after CLK↑ | 3* | | 2 | | ns |

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

switching characteristics over recommended operating conditions (unless otherwise noted) (see Figure 3)

| PARAMETER | FROM | то | SN54AS374 | | SN74A | UNIT | |
|------------------|----------------------------|----------------|-----------|------|-------|------|------|
| FARAWETER | PARAMETER (INPUT) (OUTPUT) | | MIN | MAX | MIN | MAX | UNIT |
| fmax | | | 100* | | 125 | | MHz |
| t _{PLH} | CLK | _ | 3 | 11 | 3 | 8 | ne |
| t _{PHL} | CLK | Q | 4 | 11.5 | 4 | 9 | ns |
| ^t PZH | ŌĒ | | 2 | 7 | 2 | 6 | nc |
| t _{PZL} | OE | Q | 3 | 11 | 3 | 10 | ns |
| ^t PHZ | ŌĒ | Q | 2 | 10 | 2 | 6 | ne |
| t _{PLZ} | OE . | l ^q | 2 | 7 | 2 | 6 | ns |

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

APPLICATION INFORMATION

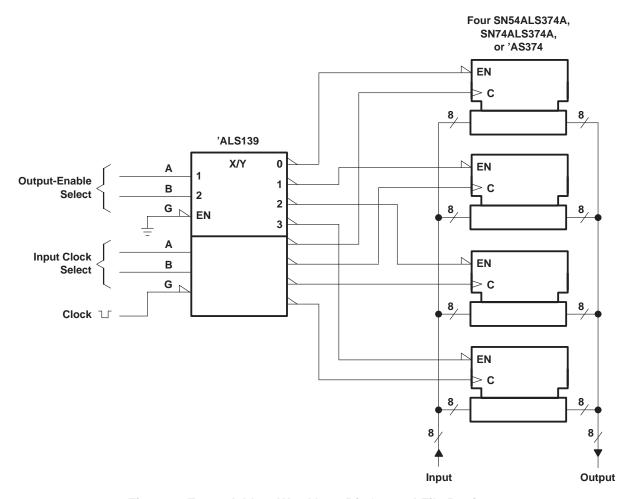


Figure 1. Expandable 4-Word by 8-Bit General File Register



SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

APPLICATION INFORMATION

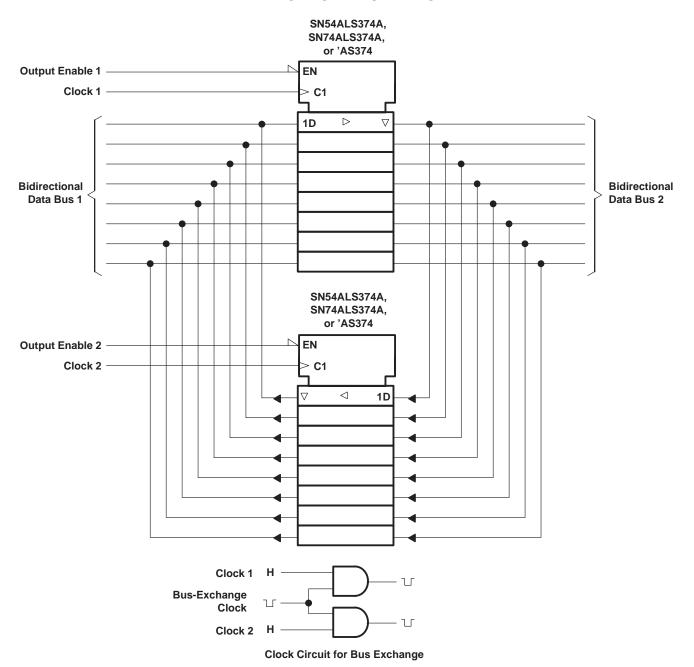
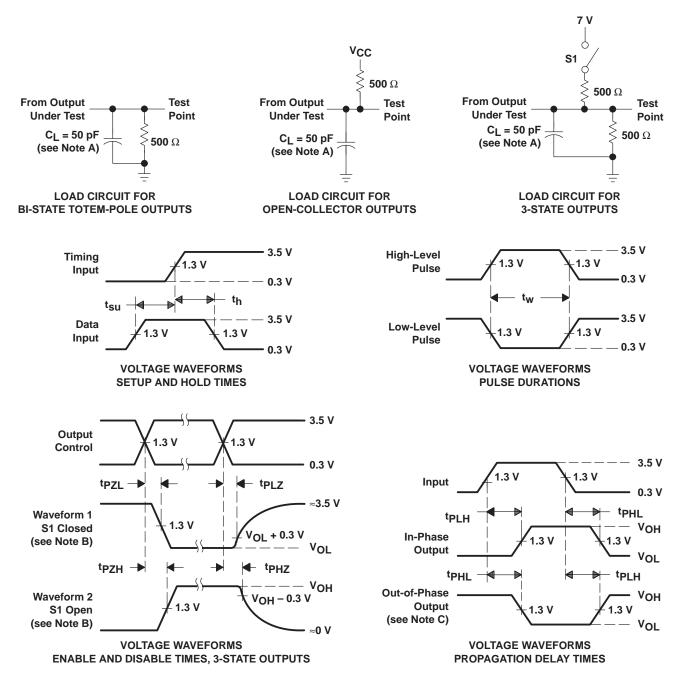


Figure 2. Bidirectional Bus Driver

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_{\Gamma} = t_{f} = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 3. Load Circuits and Voltage Waveforms



IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1999, Texas Instruments Incorporated